Ref#	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	4	("4517512" "6210983" "6625556" "7010451").PN.	US-PGPUB; USPAT	OR	ON	2006/05/24 11:31
L2	963	(702/57-59).CCLS.	US-PGPUB; USPAT	OR	OFF	2006/05/24 12:10
L3	859	(702/81-84).CCLS.	US-PGPUB; USPAT	OR	OFF	2006/05/24 12:10
L4	801	(702/89,108).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/05/24 12:12
L5	910	(702/117).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/05/24 12:14
L6	529	(702/118,119).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/05/24 12:19
L7	677	(702/120,121,123,125).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/05/24 12:53
L8	1294	(324/73.1).CCLS.	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/05/24 13:03
L9	237	(324/500,537,754,765).ccls. and parametric adj test\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:05
L10	248	(324/500,537,754,765).ccls. and (concurrent\$2 simultaneous\$2 synchronous\$2 multitasking) with control	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:06
LII	54	(438/14,16,17).ccls. and parametric adj test\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:08
L12	90	(438/14,16,17).ccls. and (concurrent\$2 simultaneous\$2 synchronous\$2 multitasking) with control	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:09
L13	1	(parametric and (test testing tested)).ti. and (load with wafer) same (automated or automatic\$)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:10
L14	7	parametric adj test\$3 and (concurrent\$2 simultaneous\$2 synchronous\$2 multitasking) with control and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:15

L15	4	parametric adj test\$3 and (concurrent\$2 simultaneous\$2 synchronous\$2	US-PGPUB;	OR	ON	2006/05/24 13:17
		multitasking) with (controller controlling) and @pd>"20060119"	USPAT; EPO; JPO; DERWENT ; IBM_TDB			
L16	2	parametric adj test\$3 and (concurrent\$2 simultaneous\$2 synchronous\$2 multitasking) with ((wafer adj (loader positioner chuck)) (wafer adj tray adj loader) prober) and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:19
L17	0	parametric adj test\$3 and synchroniz\$3 with ((wafer adj (loader positioner chuck)) (wafer adj tray adj loader) prober)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:19
L18	0	parametric adj test\$3 and synchronization with ((wafer adj (loader positioner chuck)) (wafer adj tray adj loader) prober)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:19
L19	1	parametric adj test\$3 and ((wafer adj (loader positioner chuck)) (wafer adj tray adj loader) prober) same initializ\$3 near (data instrumentation instrument)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:19
L20	1	parametric adj test\$3 and ((wafer adj (loader positioner chuck)) (wafer adj tray adj loader) prober) same initializ\$3 near file	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:19
L21	1	parametric adj test\$3 and ((wafer adj (loader positioner chuck)) (wafer adj tray adj loader) prober) same load near test	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:20
L22	1	parametric adj test\$3 and ((prepare adj wafer) (move adj probe)) same initializ\$3 near (data instrumentation instrument)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:20
L23	0	parametric adj test\$3 and ((prepare adj wafer) (move adj wafer) (move adj probe)) same initializ\$3 near file	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:20
L24	0	parametric adj test\$3 and ((prepare adj wafer) (move adj wafer) (move adj probe)) same load near test and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:21
L25	0	parametric adj test\$3 and ((wafer adj (loader positioner chuck)) (wafer adj tray adj loader) prober) same initializ\$3 near memory	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:21
L26	0	parametric adj test\$3 and state adj oscillator and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:21
L27	1	state adj oscillator same fault-tolerant same test\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:22

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L28	1	state adj oscillator same fault-tolerant	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:22
L29	1	state adj oscillator same test\$3 and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:22
L30	1	state adj oscillator same state near module	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:22
L31	0	state adj oscillator same state near object	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:23
L32	0	state adj oscillator same control adj state and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:23
L33	0	state adj oscillator same superstate and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:23
L34	0	parametric adj test\$3 and (control controlling) adj state and @pd>"20060119"	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 13:24

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Ref#	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
Ll	10	parametric adj test\$3 and concurrent adj operation	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 18:20
L2	0	parametric adj test\$3 and simultaneous adj operation	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 18:31
L3	4	alignment with initialization with (concurrent\$2 simultaneous\$2)	US-PGPUB; USPAT; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/05/24 18:34
L4	0	(semiconductor and parametric and test and control and concurrent).clm.	US-PGPUB	OR	ON	2006/05/24 18:34